

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination KIKUCHI ET AL.	
		09/943,667	Examiner	Art Unit 2822
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.